Application/Control No. Applicant(s)/Patent Under Reexamination 10/629,930 LEFEBVRE ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Phu K. Nguyen 2628 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY * 05-2004 US-6,731,314 Cheng et al. 715/848 В US-7,015,919 03-2006 Stauffer et al. 345/543 С US-6,880,129 04-2005 Lee et al. 715/763 US-D US-Ε US-F US-G US-Н US-US-Κ US-US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

W